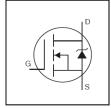


AUIRFR3504

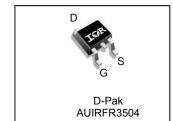
HEXFET® Power MOSFET

Features

- Advanced Planar Technology
- Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- · Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}		40V
R _{DS(on)}	typ.	7.8mΩ
	max.	9.2mΩ
I _D (Silicon Limited)		87A®
I _{D (Package Li}	imited)	56A



G	D	S
Gate	Drain	Source

Description Specifically designed for Automotive applications, this Stripe Planar design of HEXFET® Power MOSFETs utilizes the latest

processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

Boss part number	Dookogo Typo	Standard Pack		Orderable Part Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number	
AUIRFR3504	D Dak	Tube	75	AUIRFR3504	
AUIRER3304	D-Pak	Tape and Reel Left	3000	AUIRFR3504TRL	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	87®		
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	61®	1 ,	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	56	Α	
I _{DM}	Pulsed Drain Current ①	350]	
P _D @T _C = 25°C	Maximum Power Dissipation	140	W	
	Linear Derating Factor	0.92	W/°C	
V_{GS}	Gate-to-Source Voltage	± 20	V	
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	240	m l	
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value ® ⑦	480	- mJ	
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	Α	
E _{AR}	Repetitive Avalanche Energy ®		mJ	
T_J	Operating Junction and	-55 to + 175		
T _{STG}	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds (1.6mm from case)	300		

Thermal Resistance

Symbol Parameter		Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		1.09	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ®		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

2015-11-23

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.041		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		7.8	9.2	mΩ	V _{GS} = 10V, I _D = 30A ④**
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Trans conductance	40			S	$V_{DS} = 10V, I_D = 30A @**$
	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 40V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			200	nA	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-200	I IIA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

		-	-		
Total Gate Charge		48	71		I _D = 30A**
Gate-to-Source Charge		12	18	nC	$V_{DS} = 32V$
Gate-to-Drain Charge		13	20		V _{GS} = 10V4
Turn-On Delay Time		11			$V_{DD} = 20V$
Rise Time		53		20	I _D = 30A**
Turn-Off Delay Time		36		ns	$R_G = 6.8\Omega$
Fall Time		22			V _{GS} = 10V4
Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
Internal Source Inductance		7.5			from package and center of die contact
Input Capacitance		2150			$V_{GS} = 0V$
Output Capacitance		580			$V_{DS} = 25V$
Reverse Transfer Capacitance		46		nΕ	f = 1.0MHz, See Fig.5
Output Capacitance		2830		рΓ	$V_{GS} = 0V$, $V_{DS} = 1.0V$ $f = 1.0MHz$
Output Capacitance		510			$V_{GS} = 0V$, $V_{DS} = 32V$ $f = 1.0MHz$
Effective Output Capacitance		870			V_{GS} = 0V, V_{DS} = 0V to 32V
	Gate-to-Source Charge Gate-to-Drain Charge Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Internal Drain Inductance Internal Source Inductance Input Capacitance Output Capacitance Reverse Transfer Capacitance Output Capacitance Output Capacitance Output Capacitance Output Capacitance	Gate-to-Source Charge —— Gate-to-Drain Charge —— Turn-On Delay Time —— Rise Time —— Turn-Off Delay Time —— Fall Time —— Internal Drain Inductance —— Input Capacitance —— Output Capacitance —— Reverse Transfer Capacitance —— Output Capacitance ——	Gate-to-Source Charge — 12 Gate-to-Drain Charge — 13 Turn-On Delay Time — 11 Rise Time — 53 Turn-Off Delay Time — 36 Fall Time — 22 Internal Drain Inductance — 4.5 Internal Source Inductance — 7.5 Input Capacitance — 2150 Output Capacitance — 580 Reverse Transfer Capacitance — 46 Output Capacitance — 2830 Output Capacitance — 510	Gate-to-Source Charge — 12 18 Gate-to-Drain Charge — 13 20 Turn-On Delay Time — 11 — Rise Time — 53 — Turn-Off Delay Time — 36 — Fall Time — 22 — Internal Drain Inductance — 4.5 — Input Capacitance Inductance — 7.5 — Input Capacitance — 580 — Reverse Transfer Capacitance — 46 — Output Capacitance — 2830 — Output Capacitance — 510 —	Gate-to-Source Charge — 12 18 nC Gate-to-Drain Charge — 13 20 Turn-On Delay Time — 11 — Rise Time — 53 — Turn-Off Delay Time — 36 — Fall Time — 22 — Internal Drain Inductance — 4.5 — Input Capacitance Inductance — 7.5 — Input Capacitance — 580 — Output Capacitance — 46 — Output Capacitance — 2830 — Output Capacitance — 510 —

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			878		MOSFET symbol
'S	(Body Diode)			07 @		showing the
	Pulsed Source Current			350	A	integral reverse
I _{SM}	(Body Diode) ①			330		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 30A^{**}, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		53	80	ns	$T_J = 25^{\circ}C$, $I_F = 30A^{**}$, $V_{DD} = 20V$
Q_{rr}	Reverse Recovery Charge		86	130	nC	di/dt = 100A/µs④
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 0.52mH, $R_G = 25\Omega$, $I_{AS} = 30$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- $\exists \quad I_{SD} \leq 30 A, \ di/dt \leq 170 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width ≤ 1.0 ms; duty cycle $\leq 2\%$.
- \circ C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- This value determined from sample failure population. 100% tested to this value in production.
- ® Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 56A.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- R_θ is measured at T_J approximately 90°C.
- ** All AC and DC test conditions based on former package limited current of 30A.



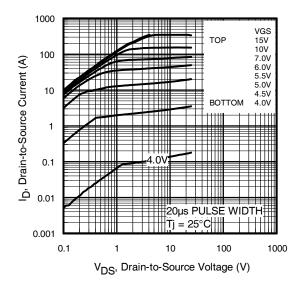


Fig. 1 Typical Output Characteristics

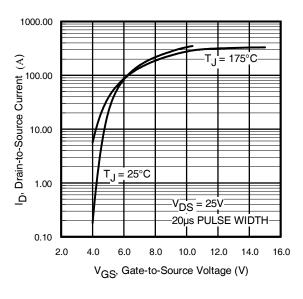


Fig. 3 Typical Transfer Characteristics

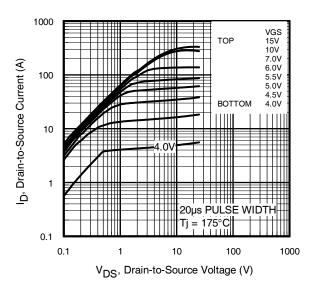


Fig. 2 Typical Output Characteristics

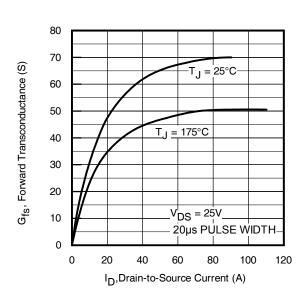


Fig. 4 Typical Forward Trans conductance Vs. Drain Current



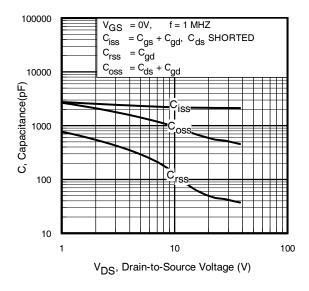


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

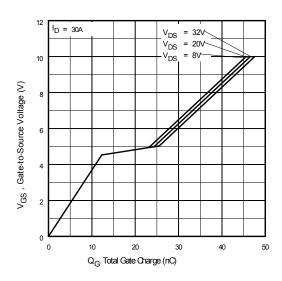


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

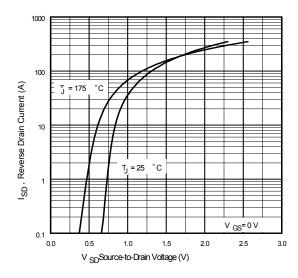


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

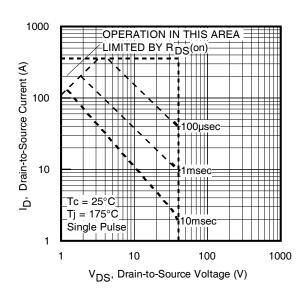
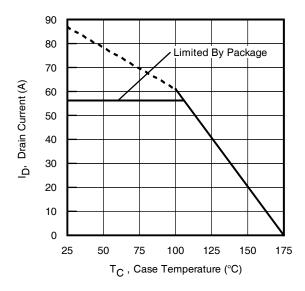


Fig 8. Maximum Safe Operating Area





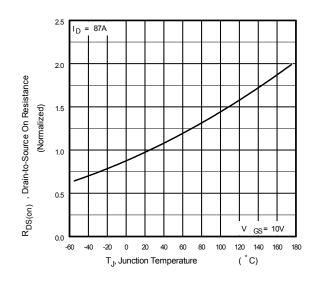


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

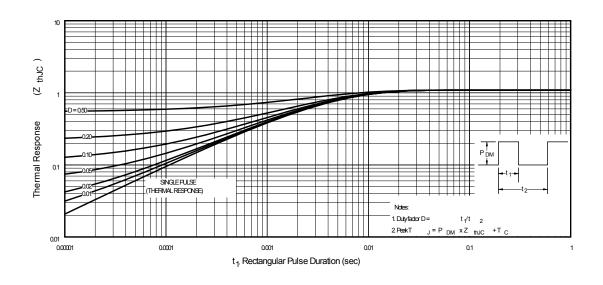


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



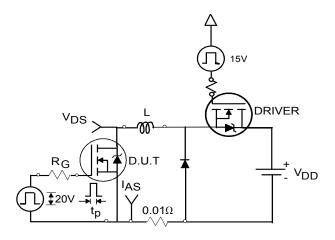


Fig 12a. Unclamped Inductive Test Circuit

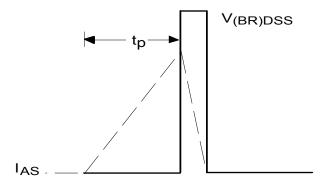


Fig 12b. Unclamped Inductive Waveforms

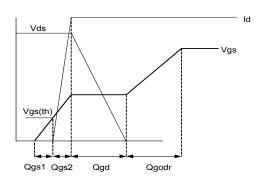


Fig 13a. Gate Charge Waveform

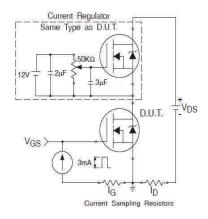


Fig 13b. Gate Charge Test Circuit

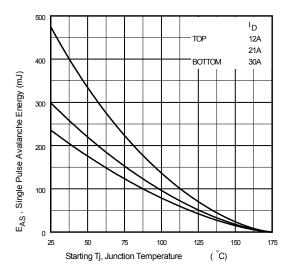


Fig 12c. Maximum Avalanche Energy vs. Drain Current

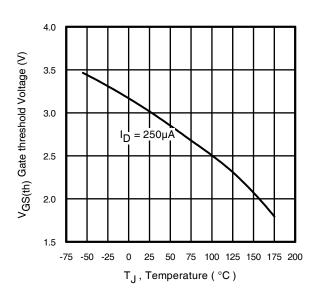


Fig 14. Threshold Voltage Vs. Temperature



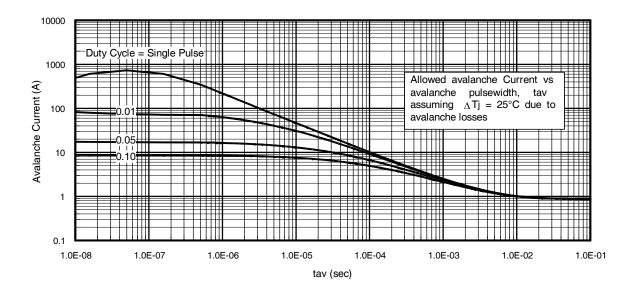


Fig 15. Typical Avalanche Current Vs. Pulse width

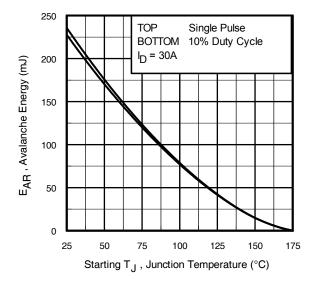


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

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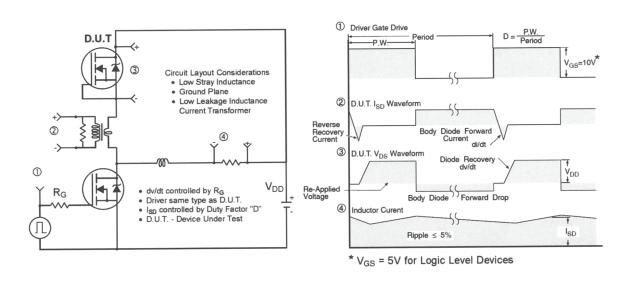
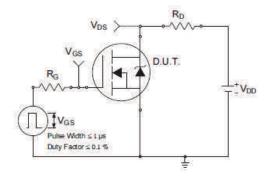
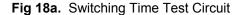


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs





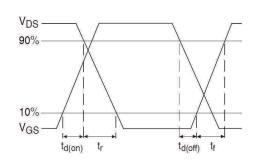
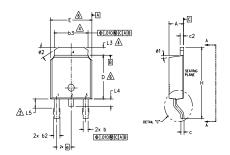


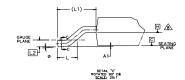
Fig 18b. Switching Time Waveforms

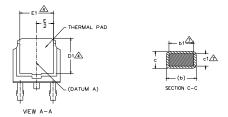


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 1 LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ___ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S		DIMEN			
Y M		N			
B	MILLIM	ETERS	INC	HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Ε	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
е	2.29	BSC	.090	BSC	
Н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
ø	0.	10°	0,	10°	
ø1	0,	15*	0,	15*	
ø2	25*	35°	25*	35*	

LEAD ASSIGNMENTS

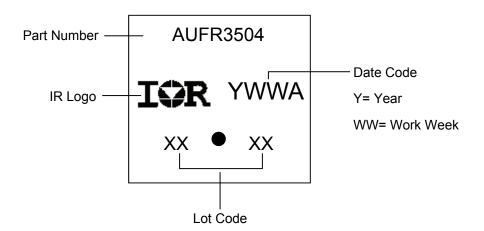
HEXFET

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4. DRAIN

IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

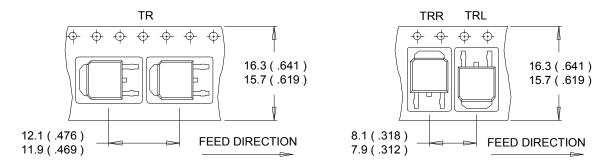
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

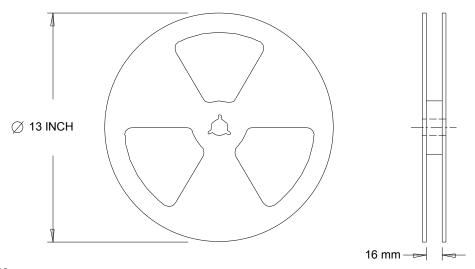


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive					
		(per AEC-Q101)					
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.					
Moisture	Sensitivity Level	D-Pak	MSL1				
			Class M4 (+/- 500V) [†]				
	Machine Model	AEC-Q101-002					
FOD	Liveran Dady Madal	Class H1C (+/- 1500V) [†]					
ESD	Human Body Model	AEC-Q101-001					
	Channed Davis Madel	Class C5 (+/- 2000V) [†]					
Charged Device Model		AEC-Q101-005					
RoHS Compliant		Yes					
1							

[†] Highest passing voltage.

Revision History

Date	Comments		
11/23/2015	Updated datasheet with corporate template		
11/23/2013	Corrected ordering table on page 1.		

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Mouser Electronics

Authorized Distributor

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